Inference for a class of partially observed point process models

James S. Martin · Ajay Jasra · Emma McCoy

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Abstract This paper presents a simulation-based framework for sequential inference from partially and discretely observed point process models with static parameters. Taking on a Bayesian perspective for the static parameters, we build upon sequential Monte Carlo methods, investigating the problems of performing sequential filtering and smoothing in complex examples, where current methods often fail. We consider various approaches for approximating posterior distributions using SMC. Our approaches, with some theoretical discussion are illustrated on a doubly stochastic point process applied in the context of finance.

Keywords Point processes · Sequential Monte Carlo · Intensity estimation